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Patent Abstracts of Japan

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APPLICANT: NKK CORP;

INVENTOR: SUYAMA TSUNEO;

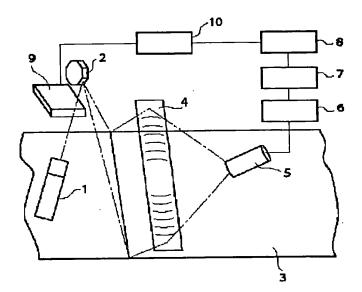
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TITLE

: SURFACE DEFECT INSPECTION

DEVICE



ABSTRACT: PROBLEM TO BE SOLVED: To diagnose normal exhibition of inspection performance without stopping a line, by adding only a device of simple structure.

> SOLUTION: A laser beam emitted from a laser beam source 1 is reflected by a rotary polygon mirror 2 to be changed into scanning light, and a surface of a steel plate 3 is scanned in the direction orthogonal to its ranning direction. Reflected light from the plate 3 is converged by a condenser lens 4 to be converted into an electric signal by a photomultiplier 5. A controllable optical element 9 is provided between the laser beam source 1 and the polygon mirror 2, and is synchronized with rotation of the polygon mirror 2 according to a command from a self-diagnosing mechanism part controlling device 10 to change the intensity of the laser beam temporarily. The reflected light from the steel plate 3 is changed, thereby generates a false defect. Self-diagnosis is conducted based on detection of the false defect as a prescribed defect signal.

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